

### 1. Global joint venture starts operations as WeEn Semiconductors

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**Product data sheet** 

## 1. General description

Planar passivated SCR with sensitive gate in a SOT223 surface mountable plastic package. This SCR is designed to be interfaced directly to microcontrollers, logic integrated circuits and other low power gate trigger circuits.

### 2. Features and benefits

- Sensitive gate
- Planar passivated for voltage ruggedness and reliability
- Direct triggering from low power drivers and logic ICs
- Surface mountable package

## 3. Applications

- General purpose switching and phase control
- Ignition circuits, CDI for 2- and 3-wheelers
- Motor control e.g. small kitchen appliances

### 4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$V_{DRM}$	repetitive peak off- state voltage			-	-	200	V
V <sub>RRM</sub>	repetitive peak reverse voltage			-	-	200	V
I <sub>TSM</sub>	non-repetitive peak on- state current	half sine wave; $T_{j(init)} = 25 ^{\circ}C$ ; $t_p = 10  \text{ms}$ ; Fig. 4; Fig. 5		-	-	8	А
I <sub>T(AV)</sub>	average on-state current	half sine wave; T <sub>sp</sub> ≤ 112 °C; <u>Fig. 1</u>		-	-	0.5	А
I <sub>T(RMS)</sub>	RMS on-state current	half sine wave; $T_{sp} \le 112$ °C; Fig. 2; Fig. 3		-	-	0.8	A
Static characte	eristics		,				,
I <sub>GT</sub>	gate trigger current	$V_D = 12 \text{ V}; I_T = 10 \text{ mA}; T_j = 25 \text{ °C};$ Fig. 9		-	50	200	μA





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# 5. Pinning information

### Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	K	cathode	4	A <del>-                                   </del>
2	Α	anode		G sym037
3	G	gate		3
4	Α	mb; connected to anode	□1 □2 □3 SC-73 (SOT223)	

# 6. Ordering information

#### Table 3. Ordering information

Type number	Package	age						
	Name	Description	Version					
MCR08BT1	SC-73	plastic surface-mounted package with increased heatsink; 4 leads	SOT223					

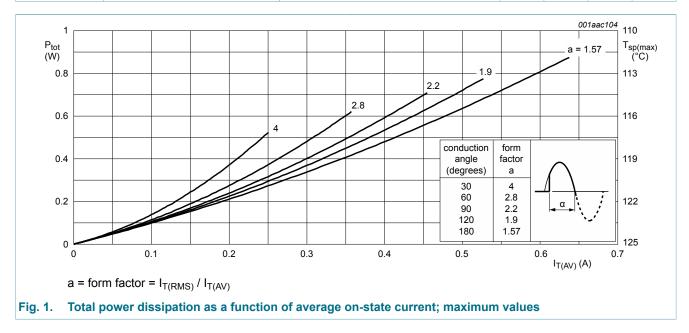
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# 7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DRM}$	repetitive peak off-state voltage		-	200	V
$V_{RRM}$	repetitive peak reverse voltage		-	200	V
I <sub>T(AV)</sub>	average on-state current	half sine wave; T <sub>sp</sub> ≤ 112 °C; <u>Fig. 1</u>	-	0.5	Α
I <sub>T(RMS)</sub>	RMS on-state current	half sine wave; $T_{sp} \le 112 ^{\circ}\text{C}$ ; Fig. 2; Fig. 3	-	0.8	А
I <sub>TSM</sub>	non-repetitive peak on-state current	half sine wave; $T_{j(init)} = 25 ^{\circ}\text{C}$ ; $t_p = 10 \text{ms}$ ; Fig. 4; Fig. 5	-	8	А
		half sine wave; $T_{j(init)} = 25 ^{\circ}\text{C}$ ; $t_p = 8.3 \text{ms}$	-	9	А
I <sup>2</sup> t	I <sup>2</sup> t for fusing	t <sub>p</sub> = 10 ms; SIN	-	0.32	A <sup>2</sup> s
dl <sub>T</sub> /dt	rate of rise of on-state current	$I_T = 2 \text{ A}$ ; $I_G = 10 \text{ mA}$ ; $dI_G/dt = 100 \text{ mA}/$ µs	-	50	A/µs
I <sub>GM</sub>	peak gate current		-	1	Α
$V_{RGM}$	peak reverse gate voltage		-	5	V
$P_{GM}$	peak gate power		-	2	W
P <sub>G(AV)</sub>	average gate power	over any 20 ms period	-	0.1	W
T <sub>stg</sub>	storage temperature		-40	150	°C
Tj	junction temperature		-	125	°C



MCR08BT1

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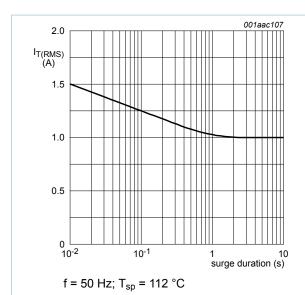


Fig. 2. RMS on-state current as a function of surge duration for sinusoidal currents; maximum values

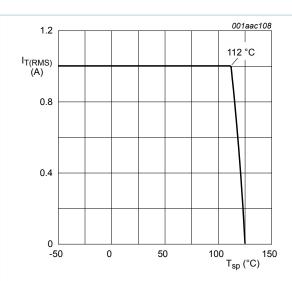
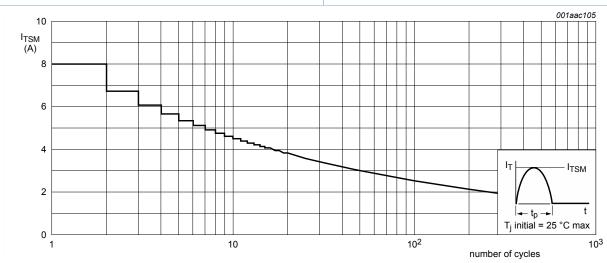


Fig. 3. RMS on-state current as a function of solder point temperature; maximum values

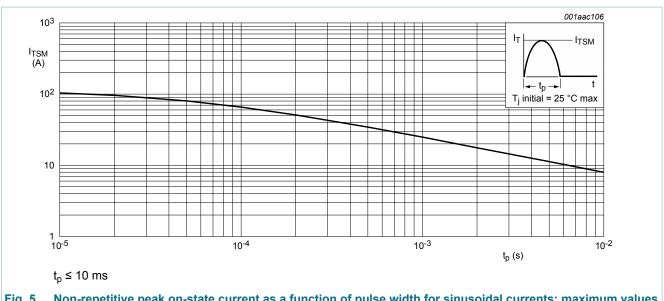


Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum Fig. 4. values

f = 50 Hz

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### 8. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-sp)</sub>	thermal resistance from junction to solder point	Fig. 6	-	-	15	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to	printed circuit board mounted; minimum pad area; in free air ; Fig. 7	-	70	-	K/W
	ambient	printed circuit board mounted; minimum footprint; in free air; Fig. 8	-	156	-	K/W

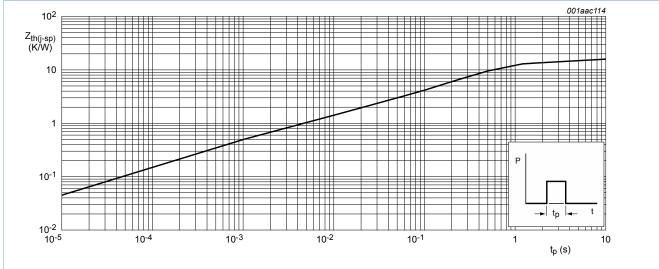
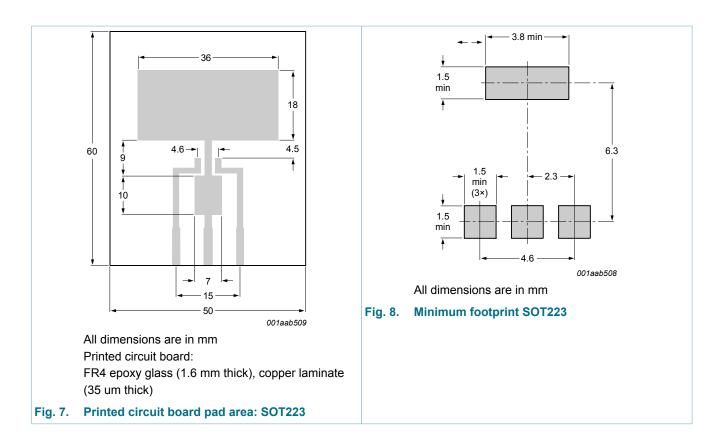


Fig. 6. Transient thermal impedance from junction to solder point as a function of pulse duration

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## 9. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	N	/lin	Тур	Max	Unit
Static cha	racteristics						
I <sub>GT</sub>	gate trigger current	$V_D = 12 \text{ V}; I_T = 10 \text{ mA}; T_j = 25 \text{ °C};$ Fig. 9	-	-	50	200	μA
lL	latching current	$V_D = 12 \text{ V}; I_G = 0.5 \text{ mA}; R_{GK} = 1 \text{ k}\Omega;$ $T_j = 25 \text{ °C}; Fig. 10$	-	-	2	6	mA
I <sub>H</sub>	holding current	$V_D = 12 \text{ V}; R_{GK} = 1 \text{ k}\Omega; T_j = 25 \text{ °C};$ Fig. 11	-	-	2	5	mA
V <sub>T</sub>	on-state voltage	I <sub>T</sub> = 1.2 A; T <sub>j</sub> = 25 °C; <u>Fig. 12</u>	-	-	1.25	1.7	V
$V_{GT}$	gate trigger voltage	$V_D = 12 \text{ V}; I_T = 10 \text{ mA}; T_j = 25 \text{ °C};$ Fig. 13	-	-	0.5	0.8	V
		$V_D = 200 \text{ V}; I_T = 10 \text{ mA}; T_j = 125 ^{\circ}\text{C};$ Fig. 13	(	0.2	0.3	-	V
I <sub>D</sub>	off-state current	$V_D = 200 \text{ V}; T_j = 125 \text{ °C}; R_{GK} = 1 \text{ k}\Omega$	-	-	0.05	1	mA
I <sub>R</sub>	reverse current	$V_R = 200 \text{ V}; T_j = 125 \text{ °C}; R_{GK} = 1 \text{ k}\Omega$	-	-	0.05	1	mA
Dynamic c	harateristics						
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$V_{DM}$ = 134 V; $T_j$ = 125 °C; $R_{GK}$ = 1 kΩ; $(V_{DM}$ = 67% of $V_{DRM}$ ); exponential waveform; Fig. 14	ŧ	500	800	-	V/µs
		$V_{DM}$ = 134 V; $T_j$ = 125 °C; ( $V_{DM}$ = 67% of $V_{DRM}$ ); exponential waveform; gate open circuit; <u>Fig. 14</u>	-	-	25	-	V/µs
t <sub>gt</sub>	gate-controlled turn-on time	$I_{TM}$ = 2 A; $V_D$ = 200 V; $I_G$ = 10 mA; $dI_G/$ dt = 0.1 A/ $\mu$ s; $T_j$ = 25 °C	-	-	2	-	μs
t <sub>q</sub>	commutated turn-off time	$V_{DM}$ = 134 V; $T_j$ = 125 °C; $I_{TM}$ = 1.6 A; $V_R$ = 35 V; $(dI_T/dt)_M$ = 30 A/µs; $dV_D/dt$ = 2 V/µs; $R_{GK}$ = 1 k $\Omega$ ; $(V_{DM}$ = 67% of $V_{DRM})$	-	-	100	-	μs

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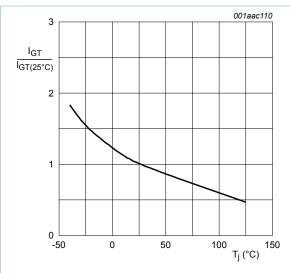


Fig. 9. Normalized gate trigger current as a function of junction temperature

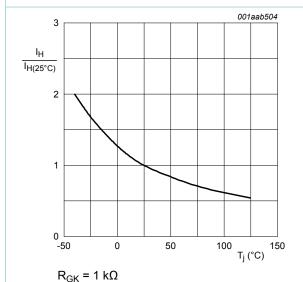
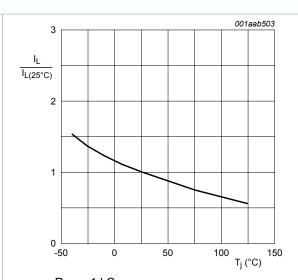
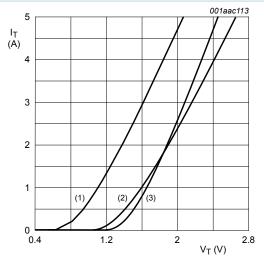


Fig. 11. Normalized holding current as a function of junction temperature



 $R_{GK} = 1 k\Omega$ 

Fig. 10. Normalized latching current as a function of junction temperature



 $V_0 = 1.0 \text{ V}; R_s = 0.27 \Omega$ 

(1) T<sub>i</sub> = 125 °C; typical values

(2) T<sub>i</sub> = 125 °C; maximum values

(3) T<sub>i</sub> = 25 °C; maximum values

Fig. 12. On-state current as a function of on-state voltage

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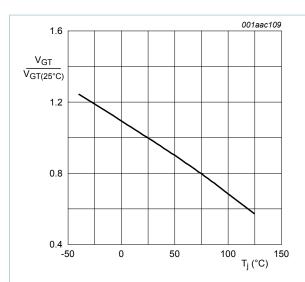
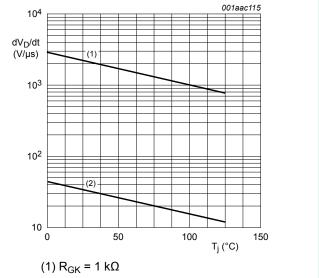


Fig. 13. Normalized gate trigger voltage as a function of junction temperature

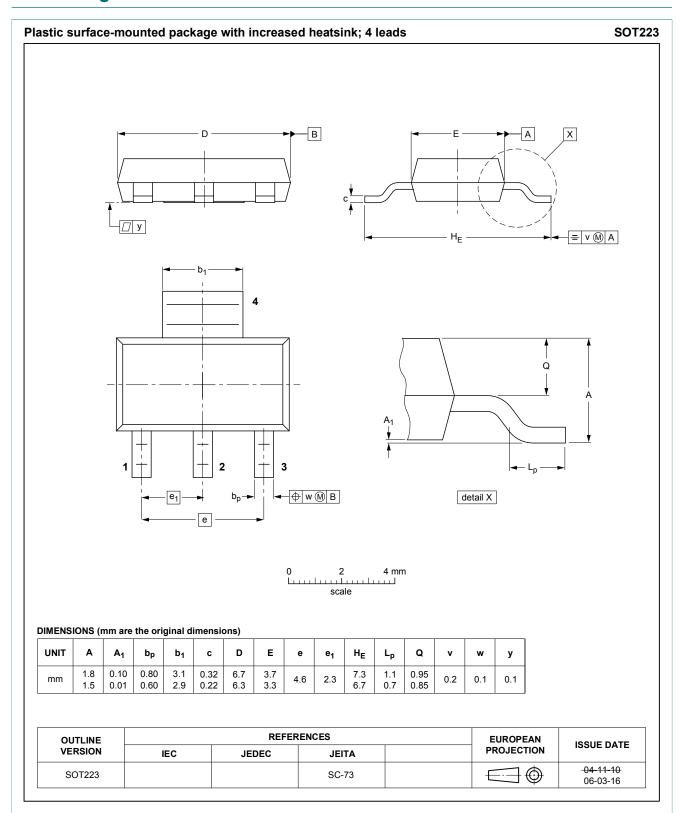


(2) Gate open circuit

Fig. 14. Critical rate of rise of off-state voltage as a function of junction temperature; typical values

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# 10. Package outline



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### 11. Legal information

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Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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